

PatBase Enhancements (March 2010)

Systran - New On the Fly Machine Translation Function

The default option for Machine Translation has now changed to Systran for Latin and Non-Latin Full text. The option to use Google Translate is still also available, giving you the option of choosing two different on-the-fly translation tools.

Control the sort order of the Family Table and Full Text View within PatBase

Under your personal display options you can now choose which order the publications appear within the family table. These customised sort options are also applied to the order in which the full text is listed. This means you can choose to display the PCT or US to be the first in the list rather than just alphabetically.



Select the sort order either by country preference, or chronological date order under **Settings=>Display and Search Options**



The Family Table and Full text will then be displayed according to the new sort settings.

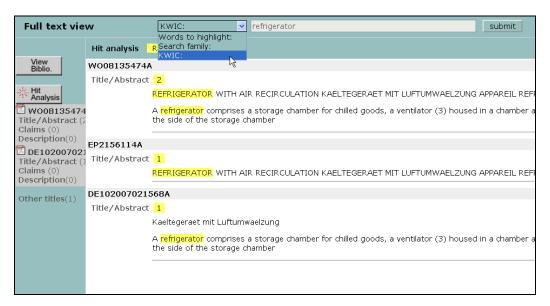
Limit the Key Word in Context View (KWIC) to specified authorities

Under the custom display options, when KWIC is selected as one of the display fields you can choose to limit the KWIC display to text from particular authorities only. Enter the Country Codes in the "Other options" box under 'Country display preference' to apply the KWIC highlighting to those countries only. This is especially useful for FTO searches when only particular authorities are relevant.

Fields to display:		
☑ Title *	✓ Abstract *	
✓ Drawing	☐ Drawing Link	
 International class 	Locarno dass	
US dass	European dass	Other options:
Japanese classes		Country display preference us wo ep e.g. DE EP WO CH
✓ Family information	Priority information	Enter country code above in order of display preference.
□ Backward Citations	☐ Forward Citations	* Indicates fields to which your country display preference will be applied, if
Number of Backward Citation:	s 🗌 Number of Forward Citations	selected.
☑ Assignee(s)	☐ Inventor(s)	
 Designated states 		Granted Publicaton if available (EP and US only)
☐ All family claims	☐ All family descriptions	
☐ Single publication daims *	☐ Single publication description *	
✓ 1st main daim *	Keyword in context (KWIC) *	

KWIC view now also available in Full Text view

You can now also apply the KWIC highlighting to the standard Full Text view in order to display the keywords in context without having to create a custom display format. At the top of the full text window select KWIC from the pull down and click on the apply button. This option is then also applied when viewing full text from other families as well.



New Export Format for Patent iNSIGHT Pro users

Patent iNSIGHT Pro users can now select a pre defined format directly from the export options screen. This facilitates the exporting of data directly into the Analysis and Visualisation software from Gridlogics. For more information on Patent iNSIGHT Pro please contact us on info@minesoft.com

г	
	Please select file format
	⊙ Microsoft Word 2000-2003
	ORich Text Format (RTF Word 2000-2003)
	ORich Text Format (zipped)
	OHTML (Web archive)
	OHTML (Web archive zipped)
	O HTML
	O PDF
	Other Formats (CSV, XML, Excel, HTML Table)
	OBizInt Smart Charts Data File
	○ VantagePoint 🅢
	O Patent iNSIGHT Pro



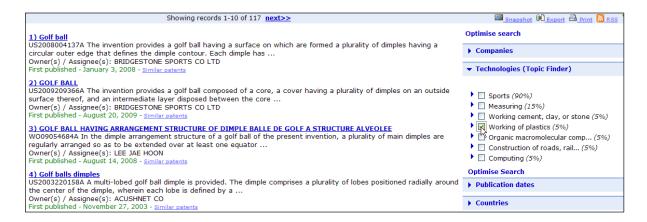
PatBase Express Enhancements (March 2010)

Search Optimiser

Use the new Search Optimiser to refine your search

Search results from PatBase Express will now be complemented by a new tool – the Search Optimiser - that displays the top companies, technology areas, publication dates and countries within your results set and allows you to narrow your search further by selecting the groups most relevant to your query.

This new feature now appears automatically to the right of your search results offering an accessible and fast way of improving search relevancy.



PatBase Express USA

A new Interface to the US data is now available to all PatBase users. Search the US data in single records, making it easier to restrict the search to different types of publications e.g. search only the text in the Granted US Patents. The database also supports the option to search the record by US serial number.

To access go to: http://www.patbase.com/usa